



SEMITRANS® 3

## IGBT4 Modules

## SKM300GB17E4

## Features\*

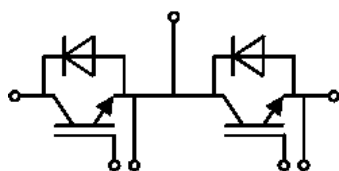
- IGBT4 = 4th generation medium fast trench IGBT (Infineon)
- CAL4 = Soft switching 4th generation CAL-Diode
- Insulated copper baseplate using DBC Technology (Direct Copper Bonding)
- With integrated Gate resistor
- For switching frequencies up to 8kHz
- UL recognized, file no. E63532

## Typical Applications

- AC inverter drives
- UPS
- Electronic welders
- Wind power
- Public transport

## Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
- Recommended  $T_{op} = -40 \dots +150^\circ\text{C}$
- Product reliability results valid for  $T_j = 150^\circ\text{C}$



GB

## Absolute Maximum Ratings

| Symbol            | Conditions                                                                      |                         | Values      | Unit |
|-------------------|---------------------------------------------------------------------------------|-------------------------|-------------|------|
| IGBT              |                                                                                 |                         |             |      |
| V <sub>CES</sub>  | T <sub>j</sub> = 25 °C                                                          |                         | 1700        | V    |
| I <sub>C</sub>    | T <sub>j</sub> = 175 °C                                                         | T <sub>c</sub> = 25 °C  | 476         | A    |
|                   |                                                                                 | T <sub>c</sub> = 80 °C  | 368         | A    |
| I <sub>Cnom</sub> |                                                                                 |                         | 300         | A    |
| I <sub>CRM</sub>  | I <sub>CRM</sub> = 3 x I <sub>Cnom</sub>                                        |                         | 900         | A    |
| V <sub>GES</sub>  |                                                                                 |                         | -20 ... 20  | V    |
| t <sub>psc</sub>  | V <sub>CC</sub> = 1000 V<br>V <sub>GE</sub> ≤ 15 V<br>V <sub>CES</sub> ≤ 1700 V | T <sub>j</sub> = 150 °C | 10          | μs   |
| T <sub>j</sub>    |                                                                                 |                         | -40 ... 175 | °C   |

## Inverse diode

|            |                                                                                |                                    |             |                    |
|------------|--------------------------------------------------------------------------------|------------------------------------|-------------|--------------------|
| $V_{RRM}$  | $T_J = 25\text{ }^{\circ}\text{C}$                                             |                                    | 1700        | V                  |
| $I_F$      | $T_J = 175\text{ }^{\circ}\text{C}$                                            | $T_c = 25\text{ }^{\circ}\text{C}$ | 314         | A                  |
|            |                                                                                | $T_c = 80\text{ }^{\circ}\text{C}$ | 231         | A                  |
| $I_{Fnom}$ |                                                                                |                                    | 300         | A                  |
| $I_{FRM}$  | $I_{FRM} = 2 \times I_{Fnom}$                                                  |                                    | 600         | A                  |
| $I_{FSM}$  | $t_p = 10\text{ ms}$ , $\sin 180^{\circ}$ , $T_J = 25\text{ }^{\circ}\text{C}$ |                                    | 1836        | A                  |
| $T_i$      |                                                                                |                                    | -40 ... 175 | $^{\circ}\text{C}$ |

## Module

|              |                                    |             |                  |
|--------------|------------------------------------|-------------|------------------|
| $I_{t(RMS)}$ |                                    | 500         | A                |
| $T_{stg}$    | module without TIM                 | -40 ... 125 | $^\circ\text{C}$ |
| $V_{isol}$   | AC sinus 50 Hz, $t = 1\text{ min}$ | 4000        | V                |

## Characteristics

| Symbol        | Conditions                                                                       | min.                      | typ.  | max.  | Unit             |
|---------------|----------------------------------------------------------------------------------|---------------------------|-------|-------|------------------|
| <b>IGBT</b>   |                                                                                  |                           |       |       |                  |
| $V_{CE(sat)}$ | $I_C = 300\text{ A}$<br>$V_{GE} = 15\text{ V}$<br>chiplevel                      | $T_j = 25^\circ\text{C}$  | 1.91  | 2.20  | V                |
|               |                                                                                  | $T_j = 150^\circ\text{C}$ | 2.29  | 2.60  | V                |
| $V_{CE0}$     | chiplevel                                                                        | $T_j = 25^\circ\text{C}$  | 0.80  | 0.90  | V                |
|               |                                                                                  | $T_j = 150^\circ\text{C}$ | 0.70  | 0.80  | V                |
| $r_{CE}$      | $V_{GE} = 15\text{ V}$<br>chiplevel                                              | $T_j = 25^\circ\text{C}$  | 3.7   | 4.3   | $\text{m}\Omega$ |
|               |                                                                                  | $T_j = 150^\circ\text{C}$ | 5.3   | 6.0   | $\text{m}\Omega$ |
| $V_{GE(th)}$  | $V_{GE} = V_{CE}$ , $I_C = 12\text{ mA}$                                         | 5.2                       | 5.8   | 6.4   | V                |
| $I_{CES}$     | $V_{GE} = 0\text{ V}$ , $V_{CE} = 1700\text{ V}$ , $T_j = 25^\circ\text{C}$      |                           |       | 4.0   | mA               |
| $C_{ies}$     | $V_{CE} = 25\text{ V}$<br>$V_{GE} = 0\text{ V}$                                  | $f = 1\text{ MHz}$        | 27.2  |       | nF               |
| $C_{oes}$     |                                                                                  | $f = 1\text{ MHz}$        | 1.06  |       | nF               |
| $C_{res}$     |                                                                                  | $f = 1\text{ MHz}$        | 0.88  |       | nF               |
| $Q_G$         | $V_{GE} = -8\text{ V} \dots +15\text{ V}$                                        |                           | 2400  |       | nC               |
| $R_{Gint}$    | $T_j = 25^\circ\text{C}$                                                         |                           | 2.1   |       | $\Omega$         |
| $t_{d(on)}$   | $V_{CC} = 1200\text{ V}$                                                         | $T_j = 150^\circ\text{C}$ | 207   |       | ns               |
| $t_r$         | $I_C = 300\text{ A}$                                                             | $T_j = 150^\circ\text{C}$ | 37.5  |       | ns               |
| $E_{on}$      | $V_{GE} = +15/-15\text{ V}$<br>$R_{G on} = 2\text{ }\Omega$                      | $T_j = 150^\circ\text{C}$ | 88    |       | mJ               |
| $t_{d(off)}$  | $R_{G off} = 2\text{ }\Omega$                                                    | $T_j = 150^\circ\text{C}$ | 756   |       | ns               |
| $t_f$         | $di/dt_{on} = 10200\text{ A}/\mu\text{s}$                                        | $T_j = 150^\circ\text{C}$ | 154   |       | ns               |
| $E_{off}$     | $di/dt_{off} = 1500\text{ A}/\mu\text{s}$<br>$dv/dt = 4500\text{ V}/\mu\text{s}$ | $T_j = 150^\circ\text{C}$ | 121   |       | mJ               |
| $R_{th(j-c)}$ | per IGBT                                                                         |                           |       | 0.083 | K/W              |
| $R_{th(c-s)}$ | per IGBT ( $\lambda_{grease} = 0.81\text{ W}/(\text{m}^2\text{K})$ )             |                           | 0.038 |       | K/W              |
| $R_{th(c-s)}$ | per IGBT, pre-applied phase change material                                      |                           | 0.023 |       | K/W              |



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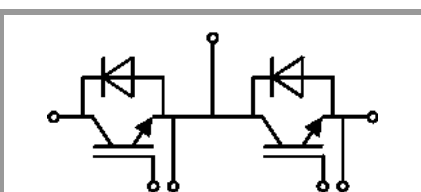
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- AC inverter drives
- UPS
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#### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max.
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- Product reliability results valid for  $T_j = 150^\circ\text{C}$

| Characteristics |                                                                                                                     |                                     |      |        |      |      |
|-----------------|---------------------------------------------------------------------------------------------------------------------|-------------------------------------|------|--------|------|------|
| Symbol          | Conditions                                                                                                          |                                     | min. | typ.   | max. | Unit |
| Inverse diode   |                                                                                                                     |                                     |      |        |      |      |
| $V_F = V_{EC}$  | $I_F = 300\text{ A}$                                                                                                | $T_j = 25\text{ }^{\circ}\text{C}$  |      | 2.00   | 2.40 | V    |
|                 | $V_{GE} = 0\text{ V}$                                                                                               | $T_j = 150\text{ }^{\circ}\text{C}$ |      | 2.13   | 2.56 | V    |
|                 | chipelevel                                                                                                          |                                     |      |        |      |      |
| $V_{F0}$        |                                                                                                                     | $T_j = 25\text{ }^{\circ}\text{C}$  |      | 1.32   | 1.56 | V    |
|                 | chipelevel                                                                                                          | $T_j = 150\text{ }^{\circ}\text{C}$ |      | 1.08   | 1.22 | V    |
| $r_F$           |                                                                                                                     | $T_j = 25\text{ }^{\circ}\text{C}$  |      | 2.3    | 2.8  | mΩ   |
|                 | chipelevel                                                                                                          | $T_j = 150\text{ }^{\circ}\text{C}$ |      | 3.5    | 4.5  | mΩ   |
| $I_{RRM}$       | $I_F = 300\text{ A}$                                                                                                | $T_j = 150\text{ }^{\circ}\text{C}$ |      | 489    |      | A    |
| $Q_{rr}$        | $di/dt_{off} = 8600\text{ A}/\mu\text{s}$                                                                           | $T_j = 150\text{ }^{\circ}\text{C}$ |      | 102    |      | μC   |
| $E_{rr}$        | $V_{GE} = -15\text{ V}$                                                                                             | $T_j = 150\text{ }^{\circ}\text{C}$ |      | 77     |      | mJ   |
|                 | $V_{CC} = 1200\text{ V}$                                                                                            |                                     |      |        |      |      |
| $R_{th(j-c)}$   | per diode                                                                                                           |                                     |      |        | 0.19 | K/W  |
| $R_{th(c-s)}$   | per diode ( $\lambda_{grease}=0.81\text{ W}/(\text{m}^*\text{K})$ )                                                 |                                     |      | 0.045  |      | K/W  |
| $R_{th(c-s)}$   | per diode, pre-applied phase change material                                                                        |                                     |      | 0.040  |      | K/W  |
| Module          |                                                                                                                     |                                     |      |        |      |      |
| $L_{CE}$        |                                                                                                                     |                                     |      | 15     |      | nH   |
| $R_{CC'+EE'}$   | measured per switch                                                                                                 | $T_C = 25\text{ }^{\circ}\text{C}$  |      | 0.55   |      | mΩ   |
|                 |                                                                                                                     | $T_C = 125\text{ }^{\circ}\text{C}$ |      | 0.85   |      | mΩ   |
| $R_{th(c-s)1}$  | calculated without thermal coupling                                                                                 |                                     |      | 0.0103 |      | K/W  |
| $R_{th(c-s)2}$  | including thermal coupling,<br>$T_s$ underneath module<br>( $\lambda_{grease}=0.81\text{ W}/(\text{m}^*\text{K})$ ) |                                     |      | 0.017  |      | K/W  |
| $R_{th(c-s)2}$  | including thermal coupling,<br>$T_s$ underneath module, pre-applied phase change material                           |                                     |      | 0.012  |      | K/W  |
| $M_s$           | to heat sink M6                                                                                                     |                                     | 3    |        | 5    | Nm   |
| $M_t$           |                                                                                                                     | to terminals M6                     | 2.5  |        | 5    | Nm   |
|                 |                                                                                                                     |                                     |      |        |      | Nm   |
| w               |                                                                                                                     |                                     |      |        | 325  | g    |



**GB**

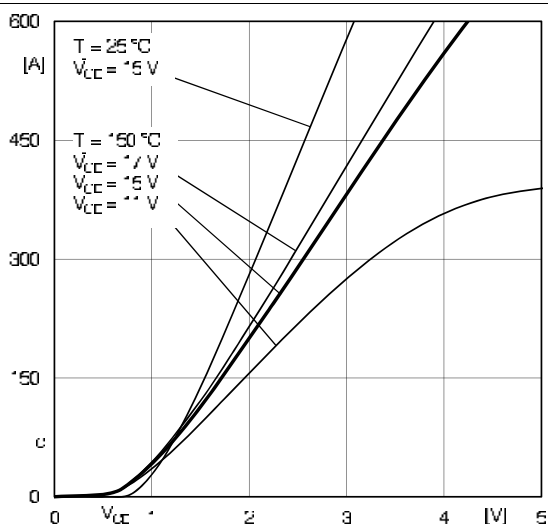


Fig. 1: Typ. output characteristic, inclusive  $R_{CC} + EE'$

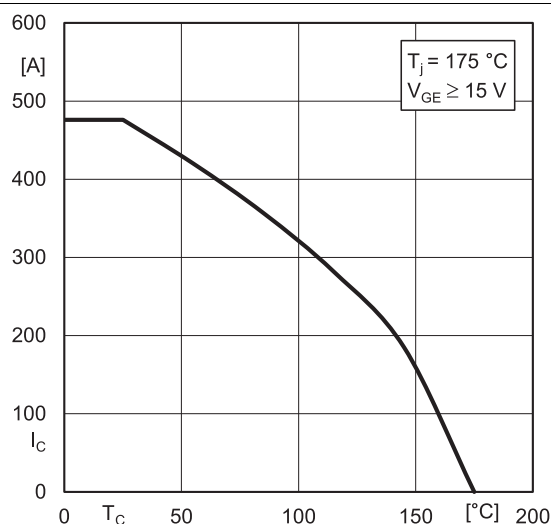


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

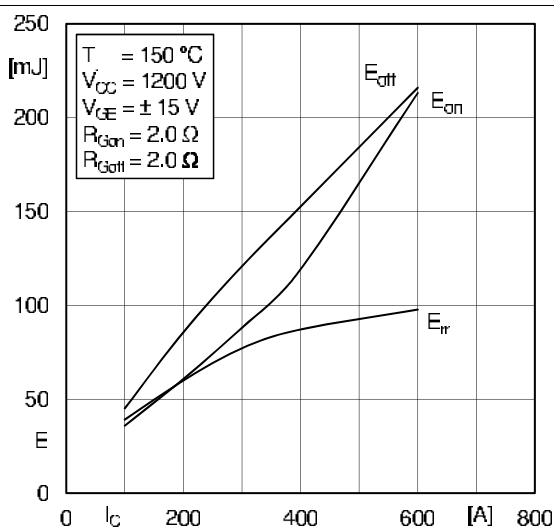


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

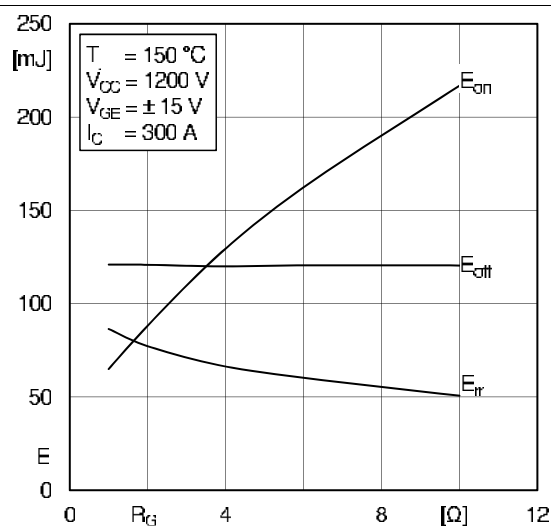


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

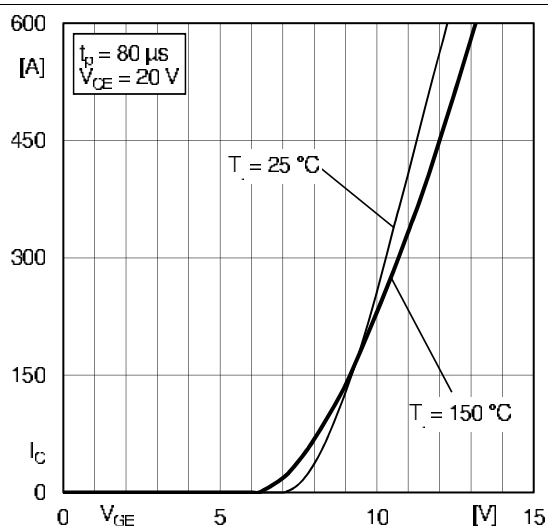


Fig. 5: Typ. transfer characteristic

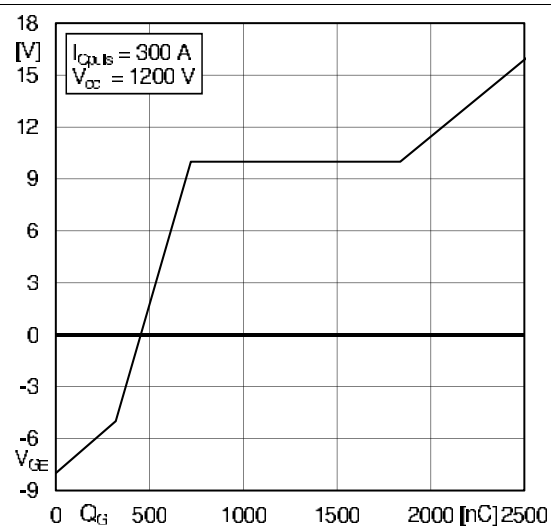


Fig. 6: Typ. gate charge characteristic

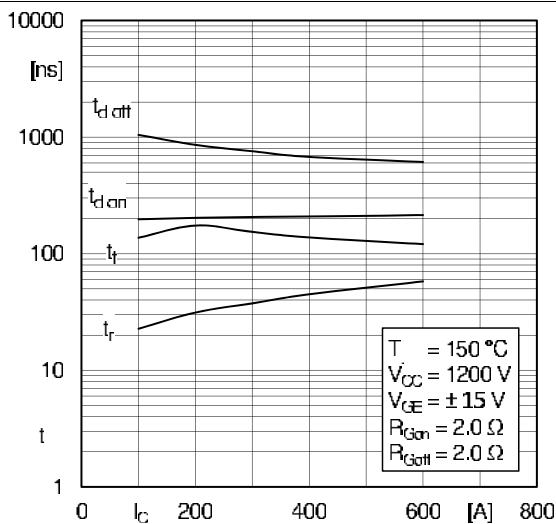


Fig. 7: Typ. switching times vs.  $I_C$

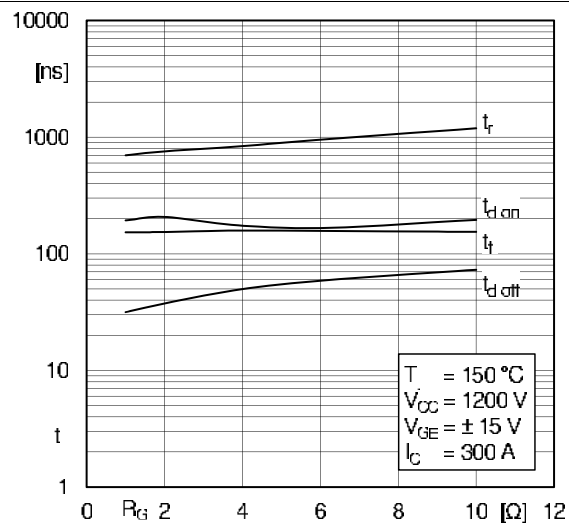


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

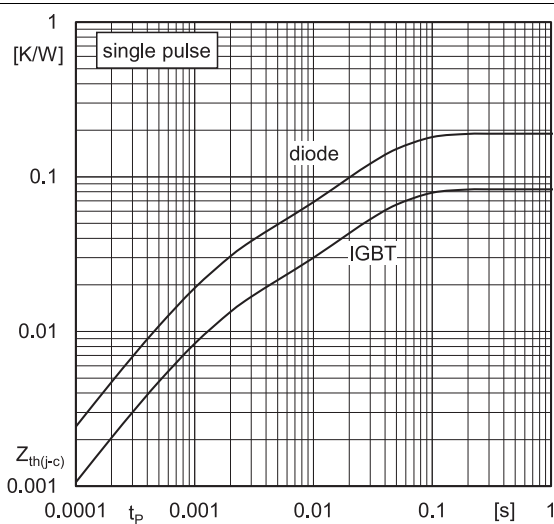


Fig. 9: Transient thermal impedance

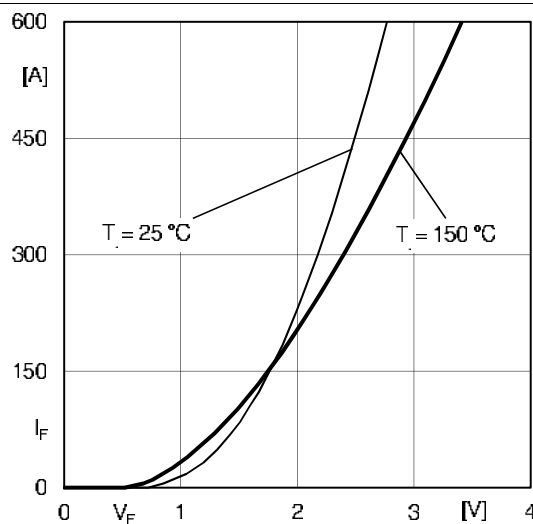


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC}'+EE'$

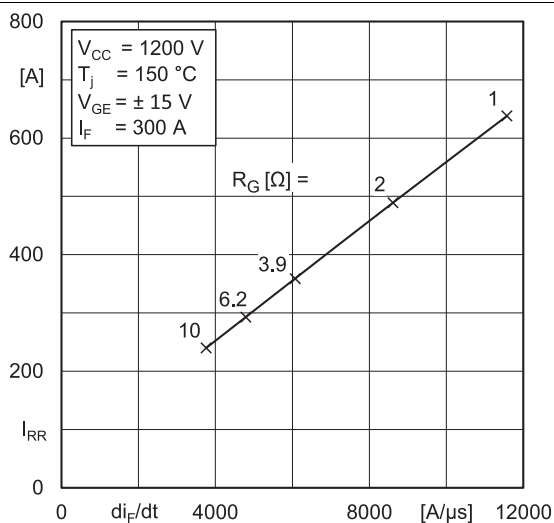


Fig. 11: Typ. CAL diode peak reverse recovery current

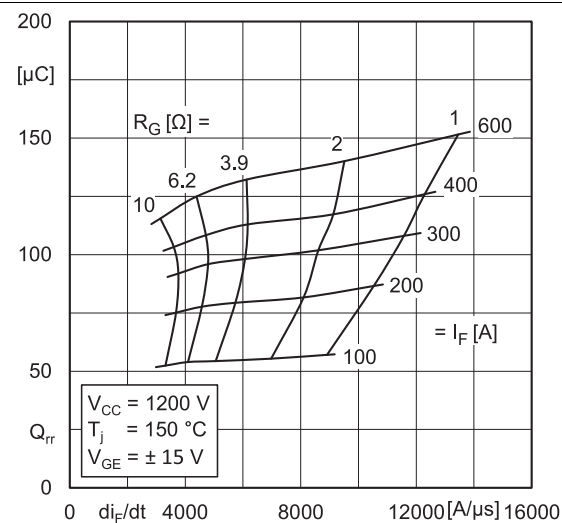
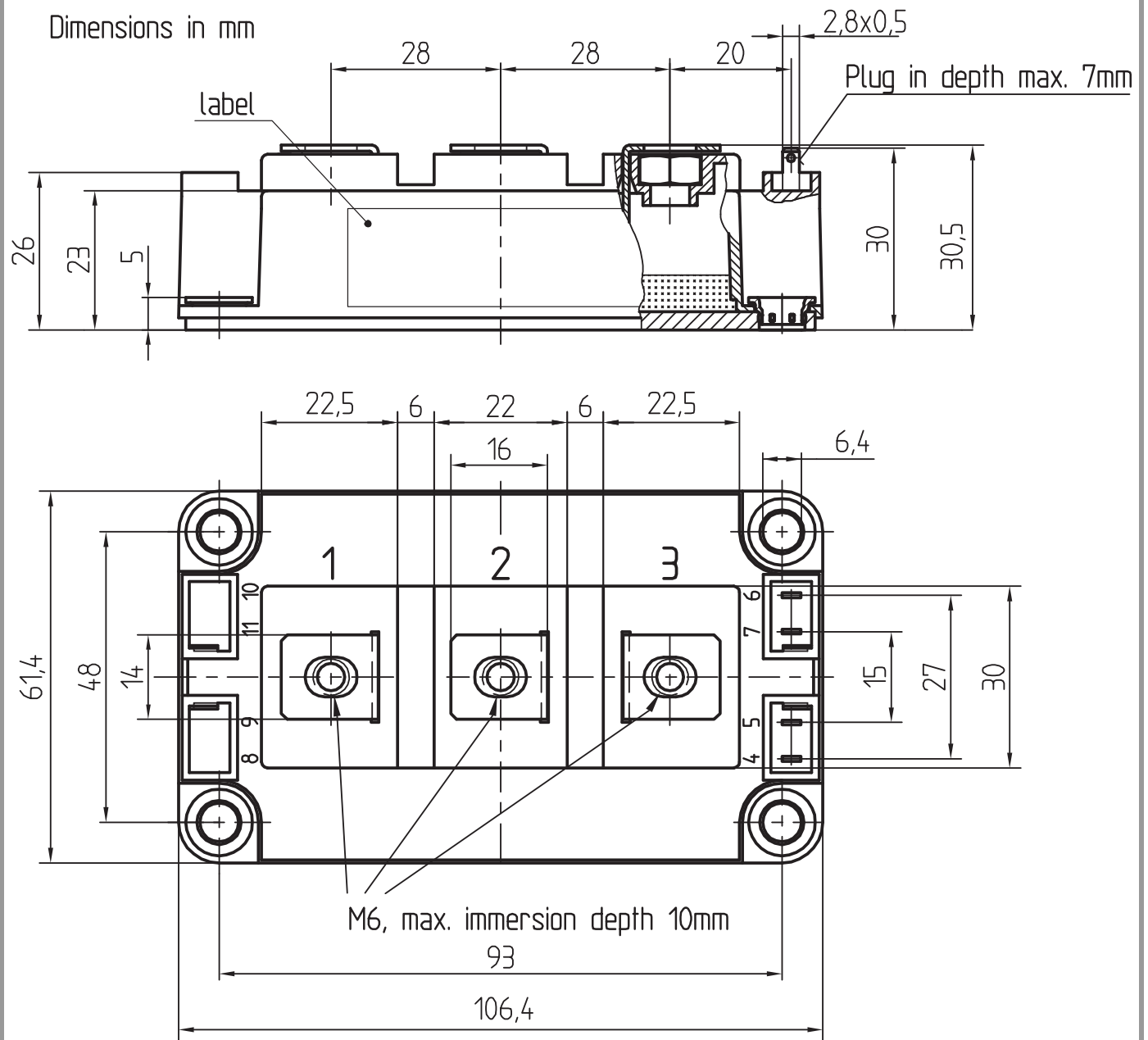
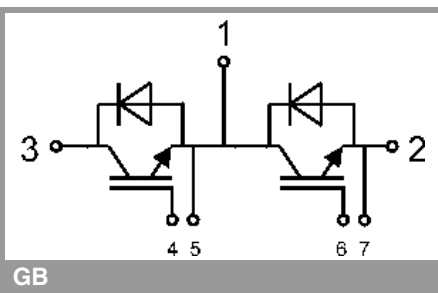


Fig. 12: Typ. CAL diode peak reverse recovery charge



General tolerance  $\pm 0,5$  mm

## SEMITRANS 3



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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